Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
‖‖‖‖‖‖‖‖‖‖ (barcode)	10/025,567	NASH ET AL.
	Examiner	**Art Unit**	
	Phuong Huynh	1644	

ISSUE CLASSIFICATION

ORIGINAL			CROSS REFERENCE(S)						
CLASS	**SUBCLASS**	**CLASS**	**SUBCLASS (ONE SUBCLASS PER BLOCK)**						
530	387.1	530	389.5	413					

INTERNATIONAL CLASSIFICATION				
C	0	7	K	16/02
C	0	7	K	16/12
A	2	3	J	1/08
				/
				/

Phuong Huynh
(Assistant Examiner)   (Date) 4/27/07

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Total Claims Allowed: 15

O.G. Print Claim(s)	O.G. Print Fig.
1	None

☒ Claims renumbered in the same order as presented by applicant   ☐ CPA   ☐ T.D.   ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	1		31		61		91		121		151		181
	2		32		62		92		122		152		182
	3		33		63		93		123		153		183
	4		34		64		94		124		154		184
	5		35		65		95		125		155		185
	6		36		66		96		126		156		186
	7		37		67		97		127		157		187
	8		38		68		98		128		158		188
	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
	11		41		71		101		131		161		191
	12		42		72		102		132		162		192
1	13		43		73		103		133		163		193
2	14		44		74		104		134		164		194
3	15		45		75		105		135		165		195
4	16		46		76		106		136		166		196
5	17		47		77		107		137		167		197
6	18		48		78		108		138		168		198
7	19		49		79		109		139		169		199
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9	21		51		81		111		141		171		201
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13	27		57		87		117		147		177		207
14	28		58		88		118		148		178		208
15	29		59		89		119		149		179		209
	30		60		90		120		150		180		210